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| Notice of References Cited | Application/Control No. 10/618,115 | | Applicant(s)/Patent Under Reexamination WEIRAUCH, CHARLES R. | |
| | Examiner Tawfik Goma | | Art Unit 2627 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------------|----------------|
| * | A | US-5,119,363 | 06-1992 | Satoh et al. | 369/275.3 |
| * | B | US-6,278,672 | 08-2001 | Kobayashi, Yoshihiro | 369/53.23 |
| * | C | US-5,684,773 | 11-1997 | Hayashi, Hideki | 369/47.35 |
| | D | US- | | | |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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